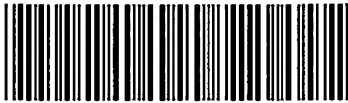


Search Notes

Application/Control No.

10/665,732

Examiner

Shih-wen Hsieh

Applicant(s)/Patent under
Reexamination

NAGASE, MAKOTO

Art Unit

2861

SEARCHED

Class	Subclass	Date	Examiner
347	22,24,28 29,30,33	6/16/2005	SWH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR